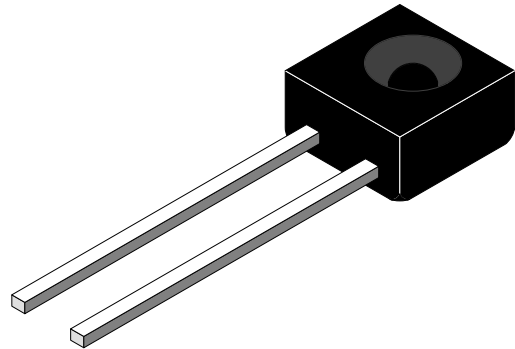


## Silicon NPN Phototransistor

### Description

BPW78 is a high sensitive silicon NPN epitaxial planar phototransistor in a flat side view plastic package. A small recessed lens provides a high sensitivity in a low profile case.

The epoxy package itself is an IR filter, spectrally matched to GaAs or GaAs on GaAlAs IR emitters ( $\lambda_p > 850\text{nm}$ ).



94 8487

### Features

- Plastic case with IR filter
- Suitable for near infrared radiation
- High radiant sensitivity
- Super flat sideview case with spherical lens
- Lens integrated
- Irradiation direction vertical to mounting direction
- Angle of half sensitivity  $\varphi = \pm 25^\circ$
- Selected into sensitivity groups
- Compatibel with CQX 48

### Applications

Detector in electronic control and drive circuits

### Absolute Maximum Ratings

$T_{\text{amb}} = 25^\circ\text{C}$

Parameter	Test Conditions	Symbol	Value	Unit
Collector Emitter Voltage		$V_{\text{CEO}}$	32	V
Emitter Collector Voltage		$V_{\text{ECO}}$	5	V
Collector Current		$I_{\text{C}}$	100	mA
Peak Collector Current	$t_p/T = 0.5, t_p \leq 10 \text{ ms}$	$I_{\text{CM}}$	200	mA
Total Power Dissipation	$T_{\text{amb}} \leq 40^\circ\text{C}$	$P_{\text{tot}}$	150	mW
Junction Temperature		$T_{\text{j}}$	100	$^\circ\text{C}$
Storage Temperature Range		$T_{\text{stg}}$	-55...+100	$^\circ\text{C}$
Soldering Temperature	$t \leq 5 \text{ s}$	$T_{\text{sd}}$	260	$^\circ\text{C}$
Thermal Resistance Junction/Ambient		$R_{\text{thJA}}$	400	K/W

## Basic Characteristics

$T_{amb} = 25^{\circ}\text{C}$

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
Collector Emitter Breakdown Voltage	$I_C = 1\text{ mA}$	$V_{(BR)CEO}$	32			V
Emitter Collector Breakdown Voltage	$I_E = 100\ \mu\text{A}$	$V_{(BR)ECO}$	5			V
Collector Dark Current	$V_{CE} = 20\text{ V}, E = 0$	$I_{CEO}$		1	100	nA
Collector Emitter Capacitance	$V_{CE} = 5\text{ V}, f = 1\text{ MHz}, E=0$	$C_{CEO}$		6		pF
Angle of Half Sensitivity		$\phi$		$\pm 25$		deg
Wavelength of Peak Sensitivity		$\lambda_p$		920		nm
Range of Spectral Bandwidth		$\lambda_{0.5}$		850...980		nm
Collector Emitter Saturation Voltage	$E_e=1\text{ mW/cm}^2, \lambda=950\text{ nm}, I_C=0.1\text{ mA}$	$V_{CEsat}$			0.3	V
Turn-On Time	$V_S=5\text{ V}, I_C=5\text{ mA}, R_L=100\ \Omega$	$t_{on}$		6		$\mu\text{s}$
Turn-Off Time	$V_S=5\text{ V}, I_C=5\text{ mA}, R_L=100\ \Omega$	$t_{off}$		5		$\mu\text{s}$
Cut-Off Frequency	$V_S=5\text{ V}, I_C=5\text{ mA}, R_L=100\ \Omega$	$f_c$		110		kHz

## Type Dedicated Characteristics

$T_{amb} = 25^{\circ}\text{C}$

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Collector Light Current	$V_{CE}=5\text{ V}, E_e=1\text{ mW/cm}^2, \lambda_p=950\text{ nm}$	BPW78A	$I_{ca}$	1	2	3	mA
		BPW78B	$I_{ca}$	2	4		mA

## Typical Characteristics ( $T_{amb} = 25^{\circ}\text{C}$ unless otherwise specified)

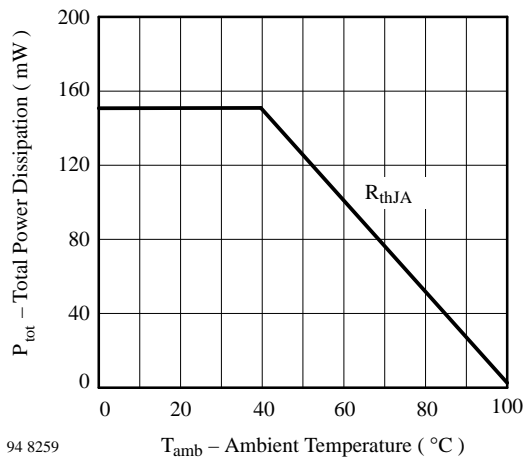


Figure 1. Total Power Dissipation vs. Ambient Temperature

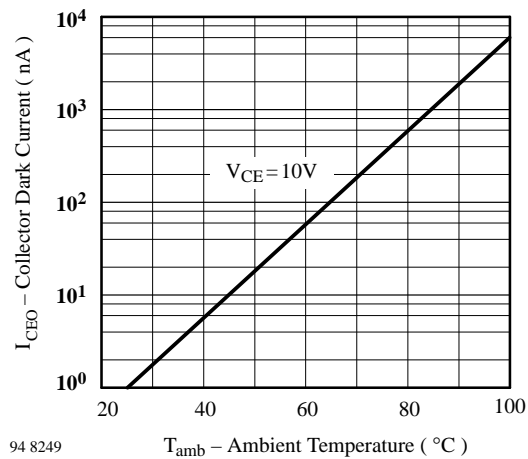


Figure 2. Collector Dark Current vs. Ambient Temperature

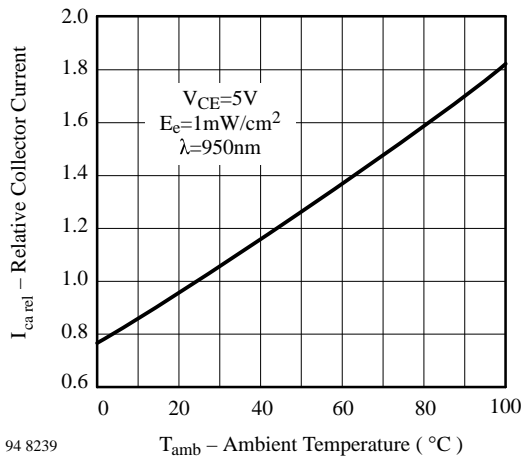


Figure 3. Relative Collector Current vs. Ambient Temperature

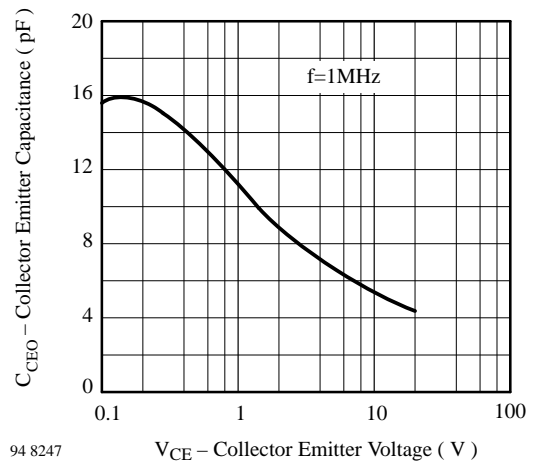


Figure 6. Collector Emitter Capacitance vs. Collector Emitter Voltage

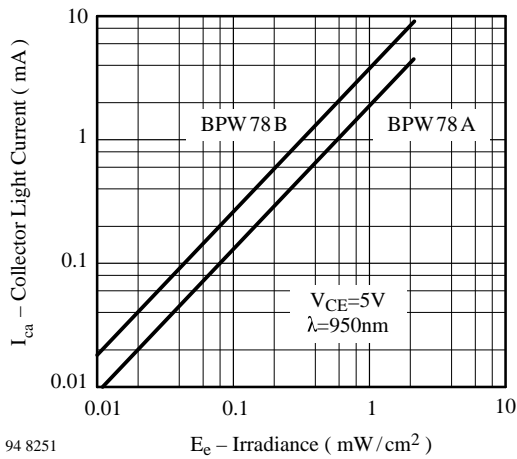


Figure 4. Relative Radiant Sensitivity vs. Angular Displacement

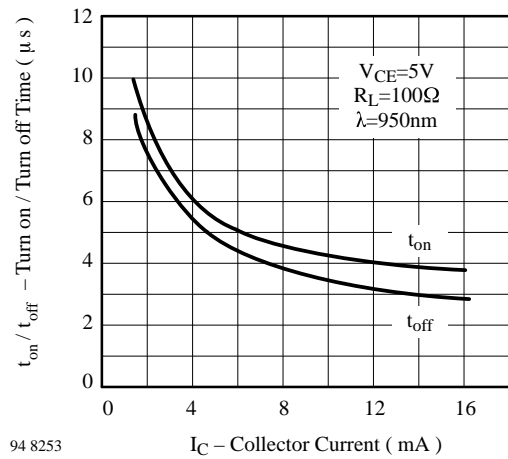


Figure 7. Turn On/Turn Off Time vs. Collector Current

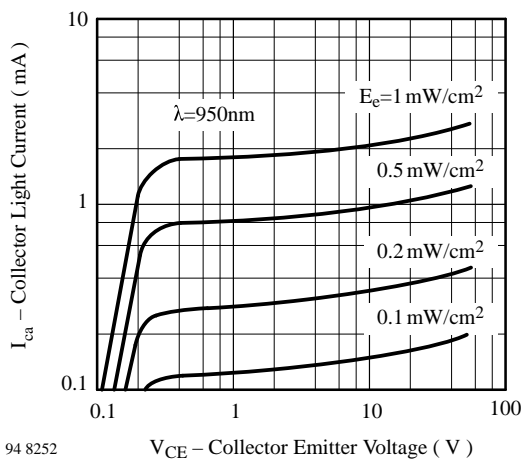


Figure 5. Collector Light Current vs. Collector Emitter Voltage

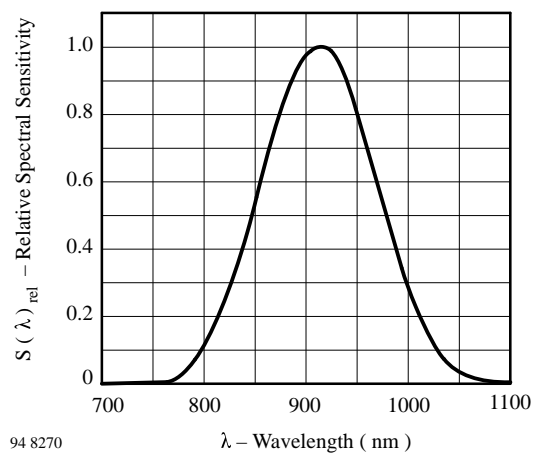
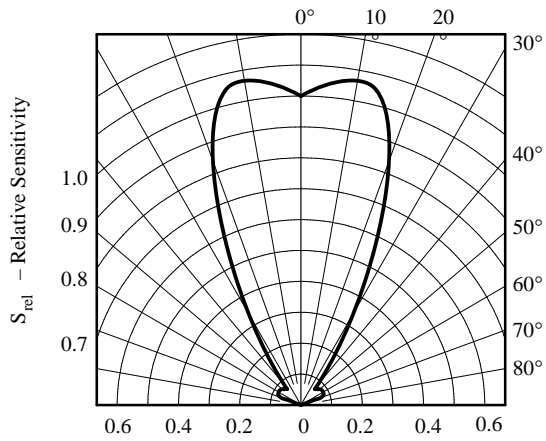


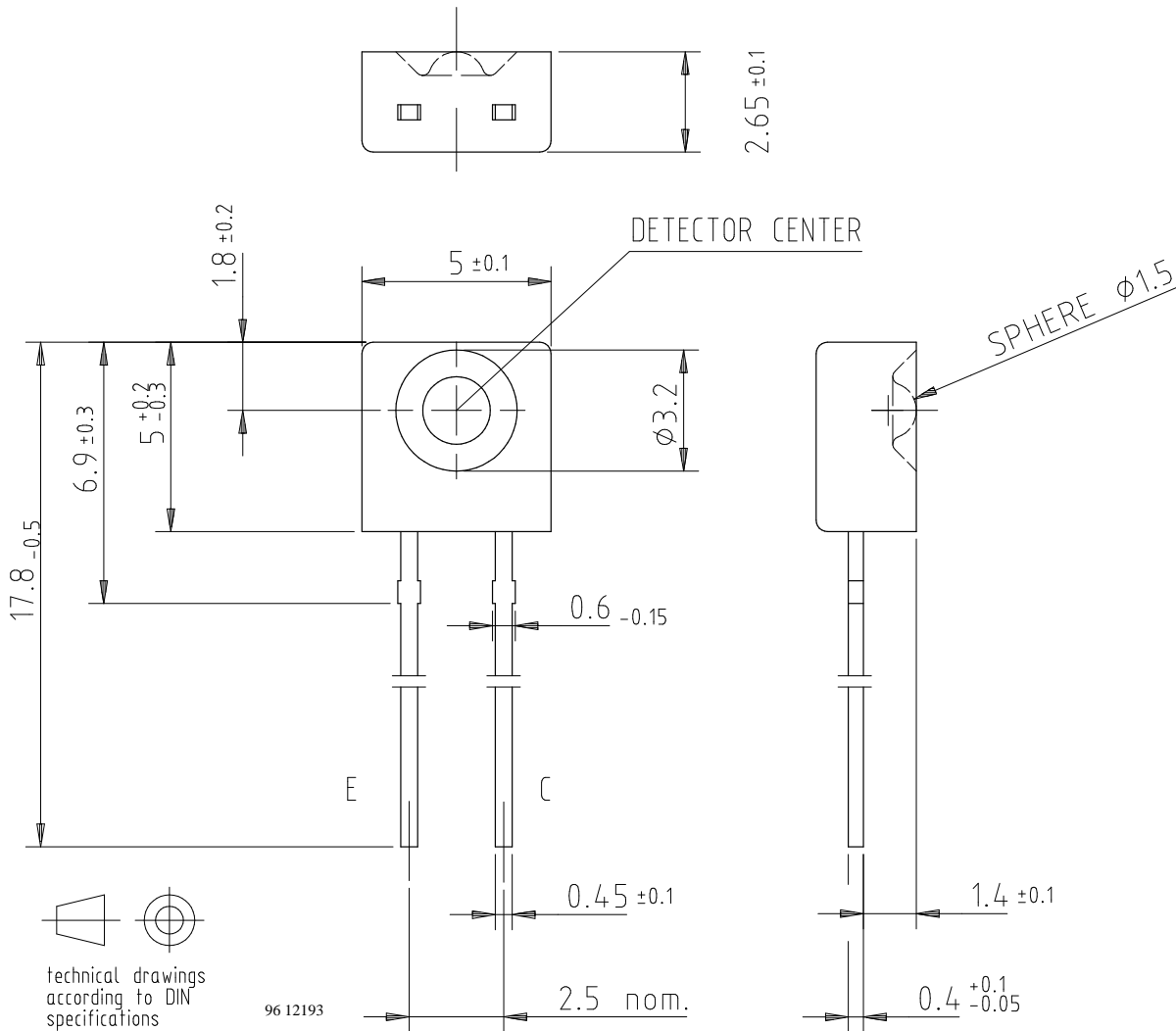
Figure 8. Relative Spectral Sensitivity vs. Wavelength



94 8254

Figure 9. Relative Radiant Sensitivity vs. Angular Displacement

## Dimensions in mm



## Ozone Depleting Substances Policy Statement

It is the policy of **TEMIC TELEFUNKEN microelectronic GmbH** to

1. Meet all present and future national and international statutory requirements.
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

**TEMIC TELEFUNKEN microelectronic GmbH** semiconductor division has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

**TEMIC** can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

**We reserve the right to make changes to improve technical design and may do so without further notice.**

Parameters can vary in different applications. All operating parameters must be validated for each customer application by the customer. Should the buyer use TEMIC products for any unintended or unauthorized application, the buyer shall indemnify TEMIC against all claims, costs, damages, and expenses, arising out of, directly or indirectly, any claim of personal damage, injury or death associated with such unintended or unauthorized use.

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